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SOME MULTIVARIATE DISTRIBUTIONS ARISING IN FAULTY SAMPLING INSPECTION

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ABSTRACT

In the present paper we extend in two ways some results presented in Kotz and Johnson (Comm. in Statistics (1982), All) relating to the study of distributional aspects of effects of errors in inspection sampling:

(1) Multistage sampling with k successive samples involving the possibility of two types of errors in inspection (classifying a defective individual as non-defective, or a non-defective as defective); (2) Single-stage sampling considering several types of defects of which only one is tested on inspection. Both (1) and (2) lead to novel multivariate distributions. Their structural properties are analysed in some detail and some applications, in particular those in quality control are discussed.

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INTRODUCTION

We have recently studied effects of inaccuracies in inspection on the properties of acceptance sampling procedures (Johnson & Kotz (1981), Kotz & Johnson (1982a,b)). In particular we have considered two-stage sampling, wherein up to two successive samples of sizes n_1, n_2 may be taken from a lot of size N, containing D defective items. (The second sample is taken only if the number (Z_1) of items found to be defective is within certain limits defined by the sampling schemes.) It was supposed that inspection is not perfect, so that some defective items may not be noticed as such, while some nondefective items may be classified as 'defective'.

Similar investigations have been described in quality control literature by Hoag et al. (1975) Dorris and Foote (1978) and Rahali and Foote (1982) (see also Armstrong (1982)). In the present paper we shall extend this work along two directions, each of which introduces apparently novel multivariate distributions.

First we shall generalize our result to multistage sampling with k successive samples of sizes n_1 , n_2 , ..., n_k and suppose that for the i-th sample

p; = probability that a defective item is correctly classified

p; = probability that a nondefective item is classified as 'defective'.

Secondly, returning to single-stage sampling we shall consider the case of two types of defects one of which is relatively easy to detect, and investigate the distribution of the second kind of defect when selection is on the basis of the first kind. As before we will suppose that p_1 denotes the probability of correct classification of a defective item and p_1' the probability of classification of a non-defective item as 'defective'.

2. MULTISTAGE SAMPLING ANALYSIS

We will be interested in the joint distribution of Z_1, Z_2, \ldots, Z_k , the numbers of items classified as defective as a result of inspection of the sequence of k samples. This distribution seems to be new, and presents some features of theoretical interest, as well as having the possible practical applications we have indicated. Chief among the latter is the possible calculation of acceptance probabilities for multi-stage (or even sequential) sampling schemes under imperfect inspection. Some practical comments, in the two-stage case are given in Kotz & Johnson (1982b).

Let $Y_1, Y_2, ..., Y_k$ denote the <u>actual</u> numbers of defectives in the 1st, 2nd,...,k-th samples respectively. The joint distribution of $Y = (Y_1, ..., Y_k)$ is a nullivariate hypergeometric with

$$\Pr\left[\begin{array}{c} \frac{k}{n} \\ i=1 \end{array} (Y_{i} - y_{i})\right] = \binom{N}{D}^{-1} \left\{ \frac{k}{n} \\ (y_{i}^{i}) \right\} \left\{ \frac{N - Dn_{i}}{D - \sum y_{i}} \right\}$$
 (1)

$$(0 \le y_i \le n_i (i=1,...,k); D-N + \frac{-k}{-i=1} n_i \le \frac{-k}{2i=1} y_i).$$

Symbolically, we write

We note that

$$E[\prod_{i=1}^{k} \{Y_{i}^{(r_{i})}(n_{i}-Y_{i})^{(s_{i})}\}] = D^{(\Sigma r_{i})}(N-D)^{(S_{i})}\{\prod_{i=1}^{k} n_{i}^{(r_{i}+s_{i})}\}/N^{(\Sigma(r_{i}+s_{i}))}$$
(2)

where $a^{(b)} = a(a-1)...(a-b+1)$ is the b-th descending factorial of a.

Conditionally on Υ , the Z's are mutually independent, with Z $_{i}$ distributed as

the sum of two independent binomial variables with parameters (Y_i, p_i) and $(n_i - Y_i, p_i)$ respectively.

$$\Pr\left[\begin{array}{c} k \\ n \\ i=1 \end{array} (Z_{i} = z_{i}) \left[\sum_{i=1}^{y=y} \left[\sum_{h=0}^{z_{i}} {y_{i} \choose h} \left(\frac{n_{i} - y_{i}}{z_{i} - h} \right) p_{i}^{h} p_{i}^{z_{i} - h} (1 - p_{i}) \right]^{n_{i} - y_{i} - z_{i} + h} \right]$$

$$= \frac{k}{n} b(z_{i}; y_{i}, p_{i}; n_{i} - y_{i}, p_{i})$$

$$= \frac{k}{n} b(z_{i}; y_{i}, p_{i}; n_{i} - y_{i}, p_{i})$$
(3)

where $b(z_i; y_i, p_i; n_i - y_i, p_i')$ is the probability function for the convolution of the two binomial distributions with parameters (y_i, p_i) and $n_i - y_i, p_i')$ respectively.

The unconditional distribution of Z is

$$\Pr[\tilde{Z} = \tilde{z}] = \binom{N}{D}^{-1} \sum_{y_1, \dots, y_k} \left\{ \binom{N-n_i}{D-y_i} \right\} \prod_{i=1}^k \binom{n_i}{y_i} \cdot \prod_{i=1}^k b(z_i; y_i, p_i; n_i - y_i, p_i^*)$$
 (4)

The limits for y are as in (1).

Symbolically

$$\mathbb{Z} \qquad \begin{bmatrix} \operatorname{Bin}(Y_{1}, p_{1}) * \operatorname{Bin}(n_{1} - Y_{1}, p_{1}^{1}) \\ \vdots \\ \operatorname{Bin}(Y_{k}, p_{k}) * \operatorname{Bin}(n_{k} - Y_{k}, p_{k}^{1}) \end{bmatrix} \qquad (4a)$$

where * stands for convolution and : is the compounding operator (as defined, for example, in Johnson & Kotz (1969, p. 184)).

This distribution might be called "Multivariate Hypergeometric-Convoluted Binomial(s)".

The conditional (on \underline{Y}) r_i -th factorial moment of Z_i is

$$E[Z_{i}^{(r_{i})}|Y] = \sum_{h=0}^{r_{i}} {r_{i} \choose h} p_{i}^{h} p_{i}^{r_{i}^{-h}} Y_{i}^{(h)} (n_{i}^{-Y_{i}})^{(r_{i}^{-h})}.$$

The unconditional $r = (r_1, ..., r_k)$ -th factorial moment of \tilde{z} is

$$\mu_{\mathbf{r}}(\mathbf{Z}) = \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_{i}^{1}) \end{bmatrix} = \mathbf{E}_{\mathbf{Y}} \mathbf{E}\begin{bmatrix} k & (\mathbf{r}_{i}^{1}) \\ k & (\mathbf{r}_$$

where g_i is the coefficient of x^i in $\sum_{j=1}^k (n_j^i + n_j x)^{r_j}$. (Note that

(i) if sampling were with replacement, (6) would be

$$u_{(\underline{r})}(\underline{z}) = \frac{p_{i}(r_{i})}{\sum_{j=1}^{k} n_{i}} \cdot \frac{k}{\sum_{j=1}^{k} Dp_{j}} + (N-D)p_{j}^{*} \cdot \frac{r_{i}}{2} \frac{Lr_{i}}{2}$$
;

(ii) if $p_i = p$ and $p_i' = p'$ for all i-corresponding to constant quality of inspection throughout – then

$$g = (\frac{r_i}{c})p'p'^{r_i}$$

In particular

$$E[Z_{i}] = n_{i}[DN^{-1}p_{i} + (1-DN^{-1})p_{i}] = n_{i}\bar{p}_{i}$$
 (7.1)

where $\tilde{p}_i = DN^{-1}p_i + (1-DN^{-1})p_i'$ is the probability that an individual chosen at random in the i-th sample will be classified as defective (whether it really is so, or not). Also

$$var(Z_{i}) = n_{i}\bar{p}_{i}(1-\bar{p}_{i}) - n_{i}(n_{i}-1)(N-1)^{-1}DN^{-1}(1-DN^{-1})(p_{i}-p_{i}^{*})^{2}$$
 (7.2)

and

and

$$cov(Z_{i},Z_{j}) = -n_{i}n_{j}(N-1)^{-1}DN^{-1}(1-DN^{-1})(p_{i}-p_{i}')(p_{j}-p_{j}')$$
 (3)

If $p_{j} > p_{j}'$ and $p_{j} > p_{j}'$ as one would hope, if inspection is to be of any use at all, the covariance is negative, as might be expected, since the covariance of Y_{i} and Y_{j} is negative. If $p_{j} = p_{j}'$ or $p_{j} = p_{j}'$, so that it is irrelevant whether an item in the corresponding sample(s) is defective or not, then the covariance is zero - in fact the corresponding Z (or Z's) is independent of all other Z's.

It is easy to write down the conditional distribution of Z_i , given Z_j , but it is rather complicated in form. We can, however, derive the regression function in the following way.

We have
$$E[Z_i|Y_i] = Y_ip_i + (n_i-Y_i)p_i$$

so
$$E[Z_i|Z_j] = p_iE[Y_i|Z_j] + p_i'(n_i-E[Y_i|Z_j])$$
 (9)

Now
$$E[Y_i | Y_j] = n_i (D-Y_j)/(N-n_j)$$

so
$$E[Y_{j}|Z_{j}] = n_{j}(N-n_{j})^{-1}(D-E[Y_{j}|Z_{j}])$$
 (10)

In order to evaluate $E[Y_j | Z_j]$ note that, for the j-th sample,

Pr[item is defective; item classified as defective] = $DN^{-1}p_{j}/\bar{p}_{j}$

Pr[item is defective|item classified as nondefective] = $DN^{-1}(1-p_j)/(1-\bar{p}_j)$

so
$$E[Y_j|Z_j] = DN^{-1}[Z_j(p_j/\bar{p}_j) + (n_j-Z_j)((1-p_j)/(1-\bar{p}_j)^{-1}]$$
 (11)

From (9), (10) and (11) we obtain

$$E[Z_{i}|Z_{j}] = n_{i}p_{i}^{i} + (p_{i}-p_{i}^{i}) E[Y_{i}|Z_{j}]$$

$$= n_{i}p_{i}^{i} + n_{i}(p_{i}-p_{i}^{i})(N-n_{j})^{-1}(D-E[Y_{j},Z_{j}])$$

$$= n_{i}p_{i}^{i} + n_{i}(p_{i}-p_{i}^{i})DN^{-1} \cdot 1 - \frac{(1-DN^{-1})(n_{j}-p_{j}^{i})}{(N-n_{j})\tilde{p}_{j}(1-\tilde{p}_{j})} \cdot (Z_{j}-n_{j}\tilde{p}_{j}); (12)$$

The regression is linear, and the sign of the regression coefficient is opposite to that of $(p_i - p_i')(p_j - p_j')$ agreeing with the sign of $cov(Z_i Z_j)$ in (8).

3. MULTISTAGE SAMPLING: A SPECIAL CASE

If we take $n_1 = n_2 = \dots = n_k = 1$ we have the first k stages of a fully sequential sampling procedure. In this situation the only possible values of each of the Y's and Z's are 0 and 1. Formula (3) becomes

$$\Pr[Z=z] = {N \choose D}^{-1} \sum_{y_1, \dots, y_k} {N-k \choose D-y_k} + \sum_{i=1}^k (y_i p_i^{z_i} (1-p_i)^{1-z_i} + (1-y_i) p_i^{z_i} (1-p_i)^{z_i} + (1-y_i) p_i^{z_i} + (1-y_i) p_i^{z_i} + (1-y_i) p_i^{z_i} + (1-y_i)^{z_i} + (1-y_i)$$

Collecting together terms with the same value of $y_i = y$ (corresponding to the total number of defective items selected) we get

$$\Pr[Z=z] = {\binom{N}{D}}^{-1} - {\binom{N-k}{D-y}} - \sum_{k=1}^{N-k} \frac{k}{j-1} p_j^{-1} \frac{i}{i} (1-p_j)^{-1} (1-p_j^{-1})^{-1}$$
(13)

where summation with respect to $z = (z_1, \ldots, z_k)$ and $z = (z_1, \ldots, z_k)$ is constrained by

$$\sum_{i=1}^{k} (x_i + \beta_i) = y$$
, and $\sum_{i=1}^{k} (x_i + \alpha_i) = \sum_{i=1}^{k} z_i = z$

(corresponding to the total number of items <u>classified</u> as defectives) and for each i, one of $(\alpha_i,\alpha_i',\alpha_i',\beta_i')$ is 1, the other three are each zero.

Yet another way of writing (13) is

$$\Pr[Z = z] = \binom{N}{D}^{-1} \sum_{y} \binom{N-k}{D-y} \cdot [\text{coefficient of } x^{z}u^{y} \text{ in}$$

$$= \frac{k}{1} \left[p_{j}xu + p_{j}^{t}x + (1-p_{j}^{t})u + 1-p_{j}^{t+1} \right]$$

$$= \frac{k}{1} \left[p_{j}^{t}xu + p_{j}^{t}x + (1-p_{j}^{t})u + 1-p_{j}^{t+1} \right]$$
(13)

It may be noted that this shows that $\sum_{i=1}^k Z_i$ is a sufficient statistic (for D, supposing N, p's and p''s are known). If $p_i = p$ and $p_i' = p'$ for all i, we have the coefficient of $x^Z u^V$ in $-pxu + p'x + (1-p)u + (1-p')^{-k}$ on the right hand side of (13)".

4. ASSOCIATED DEFECTS: ANALYSIS

We now suppose that there are two types of defects - (1) and (2) - and that in a population of size N there are D_{qh} individuals with g type (1), and h type (2) defects (g,h = 0,1). (Of course $D_{qh}+D_{qh}$

A random sample of size n is taken (without replacement) from the population; and each of the chosen individuals is examined for presence of type (1) defect. We are interested in the number (Z_{1}) of individuals classified as possessing defect (1); and among these Z_{1} individuals, the number (Z_{1}^{*}) actually possessing defect (1) and the number (Z_{2}^{*}) possessing defect (2).

The distribution of Z_1 is given in Section 2, and also in Kotz & Johnson (1982b). The distribution of Z_1^* is the hypergeometric-binomial

Binomial
$$(Y,p_1) \stackrel{\Lambda}{Y} Hypq. (n;D_{10}+D_{11};N)$$
 (14)

The probability that the sample will contain y_{gh} individuals with g type (1) defects and h type (2) defects is

$$\Pr\left[\begin{array}{ccc} 1 & 1 \\ 0 & 1 \\ 0 & 1 \end{array}\right] \left(Y_{gh} = y_{gh}\right) = \left[\begin{array}{ccc} 1 & 1 & D_{qh} \\ 0 & 1 & D_{qh} \\ 0 & 1 \end{array}\right] / {N \choose n} \qquad (y_{00} + y_{01} + y_{10} + y_{11} = n)$$
 (15)

(A multivariate hypergeometric (n; \mathbb{D} , N) distribution -cf (4a) where \mathbb{n} is a vector but D is not.) For the $\mathbb{R} = (\frac{1}{100}, \frac{1}{101}, \frac{1}{100}, \frac{1}{100})$ -th joint factorial moment of \underline{Y} we have the expresssion

$$\mu_{\left(\frac{1}{2}\right)}(\frac{y}{2}) = n^{\left(\frac{1}{4}\right)} \left[\frac{1}{2} + \frac{1}{10} + \frac{1}{10}$$

Given $y=(y_{00},y_{01},y_{10},y_{11})$, Z_1 is distributed as the sum of two independent binomial variables, with parameters $(y_{10}+y_{11},p_1)$ and $(y_{00}+y_{01},p_1)$ respectively. The first of these variables is, in fact Z_1^* . Similarly, Z_2^* is distributed as the sum of two independent binomial variables with parameters (y_{11},p_1) and (y_{01},p_1) respectively. Introducing four independent binomial variables W_{qh} with parameters (y_{qh},y_{qh}) for q, h=0,1 with $y_{qh}=y_{qh}+(1-y_{qh})$, then conditionally on $y_1=y_1$

$$Z_1 = W_{00}^{+W_{01}^{+W_{10}^{+W_{11}}}} \tag{17.1}$$

$$Z_1^* = W_{10}^{+W_{11}}$$
 (17.2)

$$Z_2^{\star} = W_{01} + W_{11}$$
 (17.3)

We have

$$E[Z_1|\underline{y}] = (y_{10} + y_{11})p_1 + (y_{00} + y_{01})p_1; var(Z_1|\underline{y}) = (y_{10} + y_{11})p_1(1-p_1) + (y_{01} + y_{00})p_1'(1-p_1')$$
(12.1)

$$E[Z_{2}^{*}|\underline{y}] = y_{11}p_{1}^{+}y_{01}p_{1}^{+}; var(Z_{2}^{*}|\underline{y}) = y_{11}p_{1}(1-p_{1}) + y_{01}p_{1}^{*}(1-p_{1}^{*})$$
(18.2)

$$cov(Z_1, Z_2^*|y) = var(W_{10} + W_{11}|y) = var(Z_2^*|y)$$
 (18.3)

$$\operatorname{corr}(Z_1, Z_2|\underline{y}) = \left\{ \operatorname{var}(Z_2|\underline{y}) / \operatorname{var}(Z_1|\underline{y}) \right\}^{\frac{1}{2}}$$
 (18.4)

$$cov(Z_1^*, Z_2^*|y) = var(W_{11}|y) = y_{11}p_1(1-p_1)$$
 (18.5)

$$corr(Z_1^*, Z_2^*|y) = \begin{bmatrix} y_{11}^2 p_1(1-p_1) \\ (y_{10}^+ y_{11}) (y_{11} p_1(1-p_1) + y_{01} p_1^*(1-p_1)) \end{bmatrix}^{\frac{1}{2}}$$
(18.6)

The distribution of Z_2^{\star} is the multivariate hypergeometric-convoluted binomial

$$\{Binomial(Y_{11},p_1)*Binomial(Y_{10},p_1')\}_{Y_{11},Y_{10}}^{N} Mult.Hypg(n;D_{11},D_{10};N)$$
 (19)

Moments can be obtained similarly as in Section 2.

For an individual chosen at random from the population

Pr[classified as having defect (1)] =
$$N^{-1}$$
: $(D_{01} + D_{00})p_1 + (D_{10} + D_{11})p_1$.
= $N^{-1}(D_0p_1 + D_1p_1) = \bar{p}_1$, say (19.1)

 $(D_1 = D_{10} + D_{11} = \text{total number of individuals in the population with defect (1);}$ $D_0 = N - D_1$)

and

Pr[having defect (2)] classified as having defect (1)] =
$$\frac{N^{-1}(D_{01}p_1'+D_{11}p_1)}{\bar{p}_1}$$

$$=\frac{\bar{p}_{2}}{\bar{p}_{1}}$$
, say (19.2)

Hence
$$E[Z_{2}^{*}|Z_{1}] = Z_{1} \bar{p}_{2}|_{1}/\bar{p}_{1}$$
 (20.1)

and (from (7.1))

$$E[Z_2^*] = n\bar{p}_{2^{-1}}$$
 (20.2)

Formula (20.1) is also valid conditionally on $\Upsilon = y$, so we have

$$cov(Z_1, Z_2^*) = \frac{\bar{p}_2|_1}{\bar{p}_1} E[Z_1^2] - n^2 \bar{p} \bar{p}_2|_1$$
 (21.1)

and from (7.2) and (7.1)

$$cov(Z_{1},Z_{2}^{*}) = \frac{n\bar{p}_{2|1}}{\bar{p}_{1}} (\bar{p}_{1}(1-\bar{p}_{1}) - \frac{n-1}{N-1} \frac{D_{1}}{N} (1-\frac{D_{1}}{N})(p_{1}-p_{1}^{*})^{2}$$
(21.2)

We must have $cov(Z_1, Z_2^*) > 0$ because from (20.1), $E[Z_2^*, Z_1]$ is an increasing function of Z_1 .

Extension to situations in which there are m (1) types of defects - (2), (3), ..., (m+1) - in addition to the type (1) which is inspected directly, is straightforward. The only essentially new problems are the joint distribution of Z_2^*, \ldots, Z_{m+1}^* - the numbers of individuals with type (2),...,(n+1) defects among those classified as having defect (1); and also the distributions of variables like $Z_{(ij)}^*$, the number among these individuals, with both (i) & (i) type defects (i \neq j \neq 2). Using an obvious notation (with subscripts O(1) indicating absence (presence) of the corresponding type of defect) we have, for example, corresponding to (19.2)

Pr[having defects (2) and (3), but not (4),...(m+1) classified as having

defect (1)] =
$$\frac{D_{0110...0}p_1' + P_{1110...0}p_1}{D_{0...p_1'} + D_{1...p_1}}$$
 (22)

where
$$D_g = \begin{bmatrix} 1 & 1 & 1 \\ a_2 = 0 & a_{m+1} = 0 \end{bmatrix} = \begin{bmatrix} 1 & 1 & 0 \\ 0 & a_2 & a_{m+1} \end{bmatrix} = \begin{bmatrix} 1 & 1 & 0 \\ 0 & a_2 & a_{m+1} \end{bmatrix} = \begin{bmatrix} 1 & 1 & 0 \\ 0 & a_2 & a_{m+1} \end{bmatrix}$$
 (g = 0,1) (D₀ is the quartity

previously represented by D_{α} .)

Considering, for simplicity, the case m=2, we now obtain an expression for $cov(Z_2^*,Z_3^*)$. We have, analogously to (17.3)

$$Z_{2}^{*} = W_{111} + W_{011} + W_{110} + W_{010}$$

$$Z_{3}^{*} = W_{111} + W_{011} + W_{101} + W_{001}$$
(23)

where the W's are independent binomial variables and the parameters of W ghi are $(y_{qhi}, \delta_q p_1 + (1-s_q)p_1)$.

Symbolically

$$\begin{array}{c|c}
Z_{2}^{*} \\
\hline Z_{3}^{*}
\end{array} \sim \text{Bin.}(Y_{111}, p_{1}) * \text{Bin}(Y_{011}, p_{1}^{*}) * \begin{cases}
\text{Bin}(Y_{110}, p_{1}) * \text{Bin}(Y_{010}, p_{1}^{*}) \\
\text{Bin}(Y_{101}, p_{1}) * \text{Bin}(Y_{001}, p_{1}^{*})
\end{cases} \times \text{Bin.}(Y_{111}, p_{1}) * \text{Bin}(Y_{001}, p_{1}^{*}) * \text{Bin}(Y_{001}, p_{1}^{*})$$

(Here $\underline{Y} = (Y_{111}, Y_{011}, Y_{110}, Y_{010}, Y_{101}, Y_{001}).)$

A general expression for the joint factorial moment $E[Z_2^*, Z_3^*]$ can be obtained in the following way.

$$Z_{2}^{(s_{2})}Z_{3}^{(s_{3})} = \{ \overline{\zeta}^{(4)}(\underline{s}_{2}^{s_{2}}) w_{111}^{(i_{1})} w_{011}^{(i_{2})} w_{110}^{(i_{3})} w_{010}^{(i_{4})} \cdots \underline{\zeta}^{(4)}(\underline{s}_{2}^{s_{3}}) w_{111}^{(j_{1})} w_{011}^{(j_{2})} w_{101}^{(j_{3})} w_{001}^{(j_{4})}$$

$$= \overline{\zeta}^{(4)} \overline{\zeta}^{(4)}(\underline{s}_{2}^{s_{2}}) (\underline{s}_{2}^{s_{3}}) \underline{\zeta}_{q=0}^{(j_{1})} (\underline{s}_{1}^{j_{1}}) \underline{\zeta}_{111}^{(j_{1}-q)} w_{111}^{(i_{1}+q)} \cdots \underline{\zeta}_{h=0}^{j_{2}} (\underline{s}_{2}^{j_{2}}) \underline{\zeta}_{2}^{(j_{2}-h)} \underline{\zeta}_{12}^{(i_{2}+h)} \cdots \underline{\zeta}_{h=0}^{(i_{2}+h)} \underline{\zeta}_{12}^{(i_{2}-h)} \underline{\zeta}_{12}^{(i_{2}+h)} \underline{\zeta}_{12}^{(i_{2}-h)} \underline{\zeta}_{11}^{(i_{2}+h)} \underline{\zeta}_{11}^{(i_{2}+h)} \underline{\zeta}_{11}^{(i_{2}+h)} \underline{\zeta}_{11}^{(i_{2}+h)} \underline{\zeta}_{11}^{(i_{2}+h)} \underline{\zeta}_{11}^{(i_{2}+h)} \underline{\zeta}_{11}^{(i_{2}+h)} \underline{\zeta}_{11}^{(i_{2}+h)} \underline{\zeta}_{12}^{(i_{2}+h)} \underline{\zeta}_{11}^{(i_{2}+h)} \underline{\zeta}_{11}^$$

where $\frac{5}{2}$ = $\frac{7}{11}$ $\frac{7}{12}$ $\frac{7}{13}$ $\frac{7}{14}$ $\frac{7}{2}$ $\frac{7}{13}$ $\frac{7}{14}$ and utilizing the $\frac{7}{11}$ = $\frac{7}{12}$ $\frac{7}{13}$ $\frac{7}{14}$ $\frac{7}{$

An expression for $E[Z_2^*]_{Z_3^*}^{(s_3)}$ [Y=y] is obtained by replacing $W_{ghi}^{(s_3)}$ in (25)

by $Y_{ghi}^{(x)}\widetilde{p}_g^x$ where $\widetilde{p}_g = y_g \cdot p_1 + (1 - y_g)p_1^x$. Then taking expectations with respect to \underline{Y} , we obtain

$$E[Z_{2}^{*}(s_{2})Z_{3}^{*}(s_{3})] = \underbrace{\sum_{i=1}^{(4)} \sum_{j=0}^{(4)} \sum_{h=0}^{j} \sum_{i=0}^{j} \sum_{h=0}^{(2)} (s_{2}) (s_{3}) (s_{4}) (s_{1}) (s_{2}) s_{1}^{g+i_{1}+i_{3}+j_{3}} s_{p_{1}}^{h+i_{2}+j_{2}+j_{4}} (26)}_{\times i_{1}} \times \underbrace{\sum_{i=1}^{(4)} \sum_{j=0}^{(4)} \sum_{h=0}^{(4)} (s_{2}^{j}) (s_{2}^{j}) (s_{3}^{j}) (s_{4}^{j}) s_{1}^{h+i_{3}+j_{3}} s_{p_{1}}^{h+i_{2}+j_{2}+j_{4}}} (26)}_{\times i_{1}} \times \underbrace{\sum_{j=1}^{(4)} \sum_{j=0}^{(4)} \sum_{h=0}^{(4)} \sum_{j=0}^{(4)} \sum_{h=0}^{(4)} (s_{2}^{j}) (s_{3}^{j}) (s_{4}^{j}) s_{1}^{h+i_{3}+j_{3}} s_{p_{1}}^{h+i_{2}+j_{2}+j_{4}}} (26)}_{\times i_{1}}$$

If m > 2, D_{ghi} is replaced by D_{ghi} ...; joint factorial moments of three or more Z_i^* 's (i > 1) can be obtained by similar techniques, though the formulas rapidly become more cumbersome.

For lower order moments, direct calculation is often simpler than using general formulas.

We now outline the calculation of $cov(Z_2^*, Z_3^*)$. We have from (23) and (24)

$$cov(7_{1}^{+}, Z_{3}^{+}|y) = y_{111}p_{1}(1-p_{1}) + y_{011}p_{1}^{+}(1-p_{1}^{+})$$
(27)

whence

$$\mathbb{E} \big[\mathbb{Z}_{2}^{\star} \mathbb{Z}_{3}^{\star} [\underline{y}] = y_{111} p_{1} (1-p_{1}) + y_{011} p_{1}^{\star} (1-p_{1}^{\star}) + . (y_{111} + y_{110}) p_{1}^{\star} (y_{011} + y_{010}) p_{1}^{\star} \big]$$

$$-(y_{111}+y_{101})r_1+(y_{011}+y_{001})p_1'$$
.

so (using (15))

cov(Z\$,Z\$)=E[Z\$Z\$]-E[Z\$]E[Z\$]

$$= \frac{n}{N} \{D_{111}p_{1}(1-p_{1})+D_{011}p_{1}'(1-p_{1}')\} + \left[\frac{n}{N} - \frac{n(n-1)}{N(N-1)} (D_{111}p_{1}^{2}+D_{011}p_{1}^{2})\right]$$

$$+ \left[\frac{n}{N} \frac{(n-1)}{(N-1)} - \frac{n^{2}}{N^{2}} ((D_{111}+D_{110})p_{1}+(D_{011}+D_{010}p_{1}')+(D_{111}+D_{101})p_{1}+(D_{011}+D_{001})p_{1}'\right]$$

$$= \frac{n}{N} \{D_{111}p_{1}(1-\frac{n-1}{N-1}p_{1})+D_{011}p_{1}'(1-\frac{n-1}{N-1}p_{1}')$$

$$= \frac{n(N-n)}{N^{2}(N-1)} ((D_{111}+D_{110})p_{1}+(D_{011}+D_{010})p_{1}')$$

$$(23)$$

This covariance can be positive or negative. Both Z_2^* and Z_3^* are positively correlated with Z_1 (the total number of individuals, classified as 'defective', of which Z_2^* and Z_3^* are subsets), but they may be negatively correlated in the population. The latter situation corresponds to values of D_{q10} and D_{q01} which are large relative to D_{q11} . (q = 0,1).

When N is large compared with n,

$$cov(Z_{2}^{*}, Z_{3}^{*}) \stackrel{?}{=} n[\bar{p}_{1|11}^{-}(\bar{p}_{1|11}^{+}, \bar{p}_{1|10}^{-})(\bar{p}_{1|11}^{+}, \bar{p}_{1|21}^{-}));$$
where $\bar{p}_{1|hi} = N^{-1}(D_{1hi}p_{1}^{+}D_{0hi}p_{1}^{+}).$
(29)

Taking as an example $p_1 = 0.90$, $p'_1 = 0.10$

$$D_{111}/N = 0.01$$
; $D_{110}/N = 0.1$; $D_{101}/N = 0.15$

$$D_{011}/N = 0.01$$
; $D_{010}/N = 0.15$; $D_{001}/N = 0.2$

we have

$$\bar{p}_{1|11} = 0.010; \; \bar{p}_{1|10} = 0.105; \; \bar{p}_{1|01} = 0.155$$

so
$$\bar{p}_{1} = (\bar{p}_{1} = 11 + \bar{p}_{1} = 10)(\bar{p}_{1} = 11 + \bar{p}_{1} = 01) = 0$$

corresponding to negative $\text{cov}(\textbf{Z}_2^{\star},\textbf{Z}_3^{\star})$.

On the other hand, if D_{111}/N and D_{011}/N are each increased to 0.05, the other parameters remaining the same, we have $\tilde{p}_{1|11}=0.050$, while $\tilde{p}_{1|10}$ and $\tilde{p}_{1|01}$ remain unchanged, so

 $\bar{p}_{1||11} = (\bar{p}_{1||11} + \bar{p}_{1||10})(\bar{p}_{1||11} + \bar{p}_{1||01}) = 0.050 - (0.155 \times 0.205) > 0$ corresponding to positive $cov(Z_2^*, Z_3^*)$.

The same formulas apply when there are m(2) types of defect other than (1), replacing D_{ghi} by D_{ghi} ...

At the cost of some elaboration in the formulas, we can allow for the possibility that presence or absence of a defect of type (2) may affect the probability of correct classification in regard to defects of type (1). Introducing the notation

 2^{p_1} $(\bar{2}^{p_1})$ for probabilities of detection of (1) in the presence (absence) of (2)

and

 $2^{p_1'}(2^{p_1})$ for probabilities of incorrect assignment of (1) when no (1) is present, in the presence (absence) of (2) we would still have a model of form (17) but the parameters of the binomial distributions of the Wgh's would now be $(y_{q0}, \frac{N}{q}, 2^{p_1} + (1-\frac{N}{q})2^{p_1'})$ for h = 0; q = 1, 2

$$(y_{q1}, \frac{1}{g}, \frac{1}{2}p_1 + (1 - \frac{1}{g})\frac{1}{2}p_1)$$
 for $h = 1$; $g = 1, 2$.

The probability of having defect (2), if classified as having (1) would be

$$\frac{D_{01} \cdot 2^{p_{1}^{+} + D_{11} \cdot 2^{p_{1}}}{D_{00} \cdot 2^{p_{1}^{+} + D_{10} \cdot 2^{p_{1}^{+} + D_{10} \cdot 2^{p_{1}^{+} + D_{11} \cdot 2^{p_{1}^{+}}}} = \frac{\bar{p}_{2}^{*} \cdot 1}{\bar{p}_{1}^{*}}$$
(30)

where $\bar{p}_{1}^{*} = \frac{1}{N}(D_{00} \cdot \bar{z}^{p_{1}^{*}} + D_{01} \cdot z^{p_{1}^{*}} + D_{10} \cdot \bar{z}^{p_{1}^{*}} + D_{11} \cdot z^{p_{1}^{*}}) = Pr[classified as having defect (1)]$

and
$$\bar{p}_{2|1}^{\star} = \frac{1}{N}(D_{01} \cdot 2^{p_1'} + D_{11} \cdot 2^{p_1})$$

Formulas (20.1) and (20.2) would still be valid, with \bar{p}_1 , $\bar{p}_{2|1}$ replaced by \bar{p}_1^* , $\bar{p}_{2|1}^*$ respectively.

Extension to situations with m(>1) types of defect, other than the one (type (1)) which is inspected directly is, again, straightforward.

In view of the model (17) which applies, with appropriate adjustments, to all the cases mentioned above, the joint distribution of Z's and Z^* 's is asymptotically multinomial as the population size N increases indefinitely, with the ratios n:D's:N remaining constant, or tending to fixed values.

5. SOME APPLICATIONS

Although this paper is concerned primarily with some novel compound multivariate discrete distribution which can arise in connection with faulty inspection rather than in specific applications, we shall indicate in this section a few circumstances in which knowledge of these distributions may be useful and directly applicable to specific investigations and inquiries.

The results in Section 2 are relevant to studies of robustness of multistage sample procedures to errors incurred in inspection and consequently to the

actual construction of such procedures. They would also be directly relevant to construction of tests for inequalities among the p_i 's and/or p_i 's which could be one aspect of attempting to detect the existence of faulty items. (Evidently if p_i and/or p_i vary with i, they cannot be identically equal to 1 or 0 respectively for all i). The distributions derived in this paper are also indirectly relevant to construction of tests of hypothesis of no faults (p = 1, p' = 0) assuming p_i , p_i do not depend on i. Some attempts in this direction have been made in Johnson & Kotz (1982) while analyses of ways in which cost consideration can be allowed for in faulty inspection problems are sketched in Kotz & Johnson (1982b).

The results in Section 4 are relevant to assessment of performance of procedures for identifying individuals with defects of type (2), say (especially in those cases when these defects are not easily detectable) by observing the existence or non-existence of defects of type (1), and the robustness of this assessment to actual numbers of faults among inspected items. In these circumstances it may sometimes be appropriate to carry out a 1000 inspection - that is, n = N - though the more general formulas we have derived are of course of greater flexibility and are useful in various situations when total inspection is either not feasible or too costly. Indeed. studies in this direction will involve introduction of cost functions allowing for costs of sampling and losses due to erroneous retention of defective individuals of type (2) and the erroneous rejection of non-defective type (2) items. See Kotz & Johnson (1982b) for an appropriate model and some preliminary results for the case of two-stage sampling with defects of a single type. Finally questions of choice of which type(s) of defects to inspect for can also arise in this context.

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UNCLASSIFIED SECURITY CLASSIFICATION OF THIS MAD INCOME PORT OF PEAL INSTRUCTION, IN FORE COMPLETING FORM REPORT DOCUMENTATION PAGE A124018 I. REPORT NUMBER 83-1 THE OF REFORTS PERCE CONFE 4. TITLE (and Subtitle) TECHNICAL Some Multivariate Distributions Arising in Faulty Sampling Inspection I THE PARTY ORG REFORT NUMBER B CONTRACT OR GRANT HUMBER N 7. AUTHOR(a) ONR Contract N00014-81-K-0301 Norman L. Johnson and Samuel Kotz NSF Grant MCS-8-21704 PERFORMING ORGANIZATION NAME AND ADDRESS PROSEAN ELEMENT FO FOT TALE Department of Management Sciences and Statistics University of Maryland College Park MD 20742
CONTROLLING OFFICE NAME AND ADDRESS 12 REPORT DAT. U.S. Office of Naval Research January 1083. NUMBER CT PAGE: Statistics and Probability Program (Code 436) 15 SECURITY CLASS (of this rep. rt) 14 MONITORING AGENCY NAME & ADDRESS(if different from Controlling Office) UNCLASSIFIED DECEASSIFICATION DOWNSHADING 16 DISTRIBUTION STATEMENT (of this Report. Approved for Public Release--Distribution Unlimited 17. DISTRIBUTION STATEMEN' (of the abstract entered with a second of the district 18. SUPPLEMENTARY NOTES 19. KEY WORDS (Continue on reverse side if necessars to a form of a idea, to the Multivariate discrete distributions; Errors in inspection; Multistage sampling; Single-stage sampling 20. ABSTRACT (Continue on reverse side if necessary and rife it is by block guiders) In the present paper we extend in two ways some results presented in Kotz and Johnson (Comm. in Statistics (1982) All, 1997-

2016) relating to the study of distributional aspects and apstage sampling with k successive samples involving the possibility of two types of errors in inspection; 2) Single-stage sampling considering several types of defects of which only one is tested on inspection. plications of effects of errors in inspection sampling: 1) Multi-

